**Product data sheet** 

## 1. General description

High-voltage, high-speed planar-passivated, NPN power switching transistor in SOT186A (TO-220F) plastic package for use in high frequency electronic lighting ballast applications

### 2. Features and benefits

- Fast switching
- High voltage capability of 700 V
- Low thermal resistance
- Isolated package

## 3. Applications

· Electronic lighting ballasts

### 4. Quick reference data

### Table 1. Quick reference data

Symbol	Parameter	Conditions	Values				Unit			
Absolute	Absolute maximum rating									
V <sub>CESM</sub>	collector-emitter peak voltage	V <sub>BE</sub> = 0 V	700				V			
I <sub>C</sub>	collector current	DC; Fig. 1; Fig. 2; Fig. 3	4			Α				
P <sub>tot</sub>	total power dissipation	T <sub>h</sub> ≤ 25 °C; <u>Fig. 4</u>	26			W				
Symbol	Parameter	Conditions		Min	Тур	Max	Unit			
Static ch	aracteristics									
h <sub>FE</sub>	DC current gain	I <sub>C</sub> = 1 A; V <sub>CE</sub> = 5 V; T <sub>h</sub> = 25 °C; Fig. 11		12	20	40				
		I <sub>C</sub> = 2 A; V <sub>CE</sub> = 5 V; T <sub>h</sub> = 25 °C; Fig. 11		10	17	28				

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# 5. Pinning information

**Table 2. Pinning information** 

Pin	Symbol	Description	Simplified outline	Graphic symbol
1	В	base	mb	
2	С	collector		С
3	Е	emitter		В
mb	n.c.	isolated		
				E sym123
				5,125
			Į Ų Ų Ų	
			1 2 3	

# 6. Ordering information

**Table 3. Ordering information** 

Type number	Package		
	Name	Description	Version
PHE13005X	TO-220F	plastic single-ended package; isolated heatsink mounted; 1 mounting hole; 3-lead TO-220 "full pack"	SOT186A

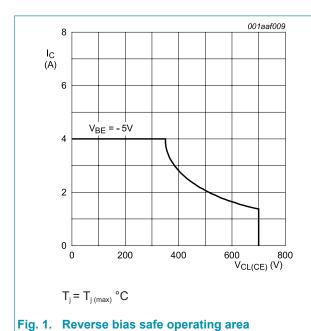
Silicon diffused power transistor

# 7. Limiting values

### **Table 4. Limiting values**

In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions	Values	Unit
V <sub>CESM</sub>	collector-emitter peak voltage	V <sub>BE</sub> = 0 V	700	V
V <sub>CBO</sub>	collector-base voltage	I <sub>E</sub> = 0 A	700	V
V <sub>CEO</sub>	collector-emitter voltage	I <sub>B</sub> = 0 A	400	V
I <sub>c</sub>	collector current	DC; Fig. 1; Fig. 2; Fig. 3	4	А
I <sub>CM</sub>	peak collector current		8	А
I <sub>B</sub>	base current		2	А
I <sub>BM</sub>	peak base current		4	Α
P <sub>tot</sub>	total power dissipation	T <sub>h</sub> ≤ 25 °C; <u>Fig. 4</u>	26	W
T <sub>stg</sub>	storage temperature		-65 to 150	°C
T <sub>j</sub>	junction temperature		150	°C



VCC
LC
VCL(CE)
probe point

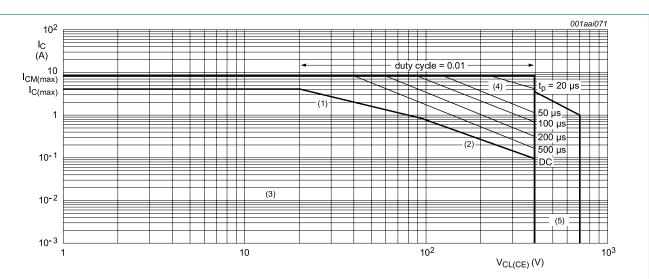
DUT

001aab999

$$\begin{split} &V_{\text{CL(CE)}} \leq 1000 \text{V}; \ V_{\text{CC}} = 150 \ \text{V}; \ V_{\text{BB}} = \text{-} 5 \ \text{V}; \\ &L_{\text{C}} = 200 \ \mu\text{H}; \ L_{\text{B}} = 1 \ \mu\text{H} \end{split}$$

Fig. 2. Test circuit for reverse bias safe operating area

### Silicon diffused power transistor

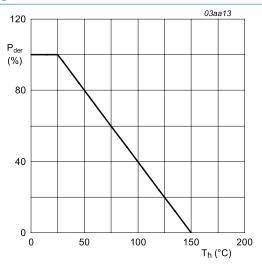


 $T_h \le 25 \,^{\circ}C$ 

Mounted with heatsink compound and (30 ± 5) N force on the center of the envelope

- (1) P<sub>tot</sub> maximum and P<sub>tot</sub> peak maximum lines
- (2) Second breakdown limits
- (3) Region of permissible DC operation
- (4) Extension of operating region for repetitive pulse operation
- (5) Extension of operating region during turn-on in single transistor converters provided that  $R_{BE} \le 100~\Omega$  and  $t_{\rm p} \le 0.6~\mu s$ .

Fig. 3. Forward bias safe operating area



$$P_{der}(\%) = \frac{P_{tot}}{P_{tot(25^{\circ}C)}} \times 100\%$$

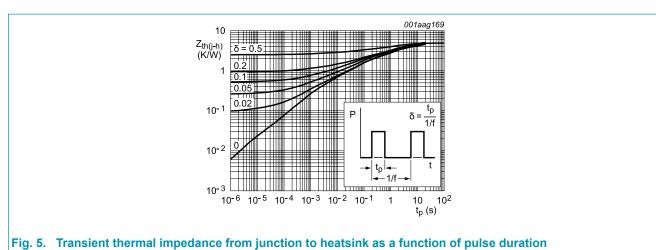
Fig. 4. Normalized total power dissipation as a function of heatsink temperature

Silicon diffused power transistor

### 8. Thermal characteristics

### **Table 5. Thermal characteristics**

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
R <sub>th(j-mb)</sub>	thermal resistance from junction to heatsink	with heatsink compound; Fig. 5	-	-	4.8	K/W
R <sub>th(j-a)</sub>	thermal resistance from junction to ambient		-	55	-	K/W



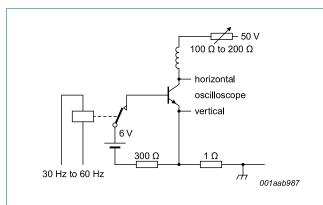
Silicon diffused power transistor

## 9. Characteristics

### **Table 6. Characteristics**

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
Static cha	racteristics					,
I <sub>CES</sub>	collector-emitter cut-off	V <sub>BE</sub> = 0 V; V <sub>CE</sub> = 700 V; T <sub>j</sub> = 25 °C	-	-	1	mA
	current	V <sub>BE</sub> = 0 V; V <sub>CE</sub> = 700 V; T <sub>j</sub> = 100 °C	-	-	5	mA
I <sub>CBO</sub>	collector-base cut-off current	$V_{CB} = 700 \text{ V}; I_E = 0 \text{ A}; T_h = 25 \text{ °C}$	-	-	1	mA
I <sub>CEO</sub>	collector-emitter cut-off current	$V_{CEO} = 400 \text{ V}; I_B = 0 \text{ A}; T_h = 25 \text{ °C}$	-	-	0.1	mA
I <sub>EBO</sub>	emitter-base cut-off current	$V_{EB} = 9 \text{ V}; I_{C} = 0 \text{ A}; T_{h} = 25 \text{ °C}$	-	-	1	mA
$V_{CEOsus}$	collector-emitter sustaining voltage	$I_B = 0 \text{ A}; I_C = 10 \text{ mA}; L_C = 25 \text{ mH};$ $T_h = 25 ^{\circ}\text{C}; \underline{\text{Fig. 6}}; \underline{\text{Fig. 7}}$	400	-	-	V
$V_{CEsat}$	collector-emitter saturation voltage	$I_{C} = 1 \text{ A}; I_{B} = 0.2 \text{ A}; T_{h} = 25 \text{ °C};$ Fig. 8; Fig. 9	-	0.1	0.5	V
		I <sub>C</sub> = 2 A; I <sub>B</sub> = 0.5 A; T <sub>h</sub> = 25 °C; Fig. 8; Fig. 9	-	0.2	0.6	V
		$I_C = 4 \text{ A}; I_B = 1 \text{ A}; T_h = 25 °C;$ Fig. 8; Fig. 9	-	0.3	1	V
	base-emitter saturation voltage	$I_C = 1 \text{ A}; I_B = 0.2 \text{ A}; T_h = 25 \text{ °C};$ Fig. 10	-	0.85	1.2	V
		$I_C = 2 \text{ A}; I_B = 0.5 \text{ A}; T_h = 25 \text{ °C};$ Fig. 10	-	0.92	1.6	V
h <sub>FE</sub>	DC current gain	$I_C = 1 \text{ A}$ ; $V_{CE} = 5 \text{ V}$ ; $T_h = 25 \text{ °C}$ ; Fig. 11	12	20	40	
		$I_C = 2 \text{ A}$ ; $V_{CE} = 5 \text{ V}$ ; $T_h = 25 \text{ °C}$ ; Fig. 11	10	17	28	
Dynamic	characteristics				·	
t <sub>s</sub>	storage time	$I_{C}$ = 2 A; $I_{Bon}$ = 0.4 A; $I_{Boff}$ = -0.4 A; $R_{L}$ = 75 $\Omega$ ; $T_{h}$ = 25 °C; resistive load; Fig. 12; Fig. 13	-	2.7	4	μs
		$I_{C}$ = 2 A; $I_{Bon}$ = 0.4 A; $V_{BB}$ = -5 V; $L_{B}$ = 1 $\mu$ H; $T_{h}$ = 25 °C; inductive load; <u>Fig. 14</u> ; <u>Fig. 15</u>	-	1.2	2	μs
		$I_{C}$ = 2 A; $I_{Bon}$ = 0.4 A; $V_{BB}$ = -5 V; $L_{B}$ = 1 $\mu$ H; $T_{h}$ = 100 °C; inductive load; <u>Fig. 14</u> ; <u>Fig. 15</u>	-	1.4	4	μs
t <sub>f</sub>	fall time	$I_{C}$ = 2 A; $I_{Bon}$ = 0.4 A; $I_{Boff}$ = -0.4 A; $R_{L}$ = 75 $\Omega$ ; $T_{h}$ = 25 °C; resistive load; Fig. 12; Fig. 13	-	0.3	0.9	μs
		$I_C = 2 \text{ A}; I_{Bon} = 0.4 \text{ A}; V_{BB} = -5 \text{ V};$ $L_B = 1  \mu\text{H}; T_h = 25 ^{\circ}\text{C}; inductive load;}$ Fig. 14; Fig. 15	-	0.1	0.5	μs
		$I_C = 2 \text{ A}; I_{Bon} = 0.4 \text{ A}; V_{BB} = -5 \text{ V};$ $L_B = 1  \mu\text{H}; T_h = 100 ^{\circ}\text{C}; inductive load;}$ Fig. 14; Fig. 15	-	0.16	0.9	μs

### Silicon diffused power transistor



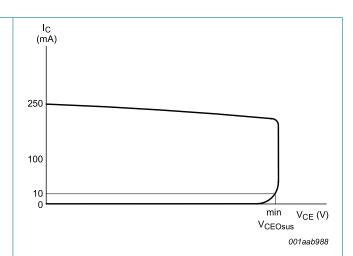
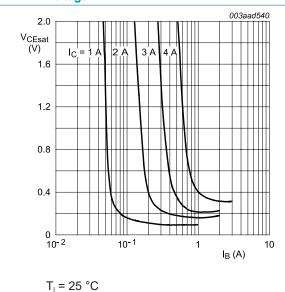


Fig. 6. Test circuit for collector-emitter sustaining voltage

Fig. 7. Oscilloscope display for collector-emitter sustaining voltage test waveform



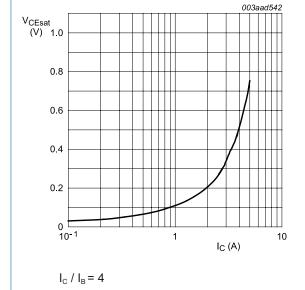


Fig. 8. Collector-emitter saturation voltage; typical values

Fig. 9. Collector-emitter saturation voltage as a function of collector current; typical values

### Silicon diffused power transistor

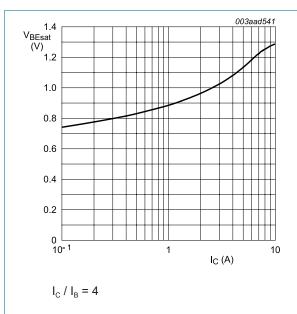
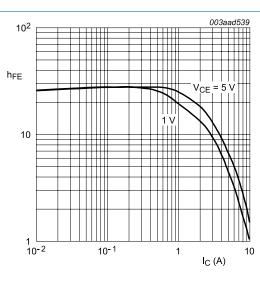


Fig. 10. Base-emitter saturation voltage; typical values



T<sub>i</sub> = 25 °C

Fig. 11. DC current gain as a function of collector current; typical values

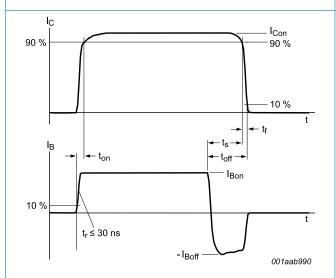
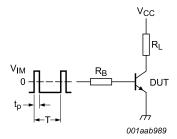


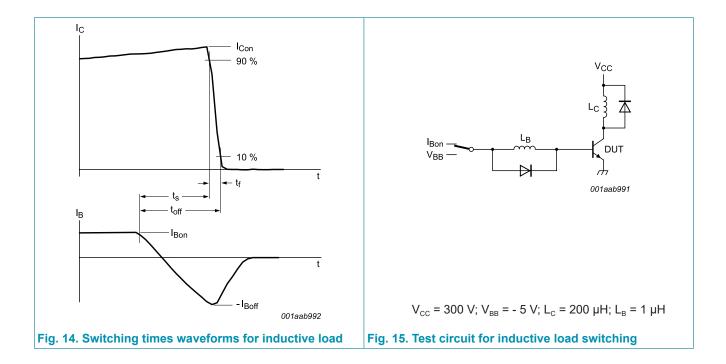
Fig. 12. Switching times waveforms for resistive load



 $V_{IM}$  = - 6 to + 8 V;  $V_{CC}$  = 250 V;  $t_{_{D}}$  = 20  $\mu s;$   $\delta$  =  $t_{_{P}}$  / T = 0.01  $R_{B}$  and  $R_{L}$  calculated from  $I_{Con}$  and  $I_{Bon}$  requirements.

Fig. 13. Test circuit for resistive load switching

### Silicon diffused power transistor



## 10. Isolation characteristics

**Table 8. Isolation characteristics** 

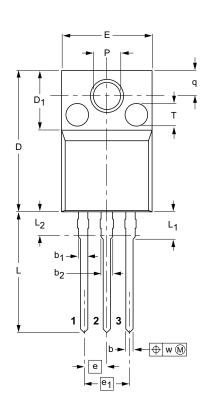
Symbol	Parameter	Conditions	Min	Тур	Max	Unit
$V_{isol(RMS)}$	RMS isolation voltage	from all terminals to external heatsink; clean and dust free; 50 Hz $\leq$ f $\leq$ 60 Hz; RH $\leq$ 65 %; T <sub>h</sub> = 25 °C	-	-	2500	V
C <sub>isol</sub>	isolation capacitance	from collector to external heatsink; f = 1 MHz; T <sub>h</sub> = 25 °C	-	10	-	pF

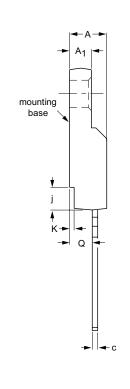
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# 11. Package outline

Plastic single-ended package; isolated heatsink mounted; 1 mounting hole; 3-lead TO-220 'full pack'

SOT186A





0 5 10 mm

### **DIMENSIONS** (mm are the original dimensions)

UNIT	Α	A <sub>1</sub>	b	b <sub>1</sub>	b <sub>2</sub>	С	D	D <sub>1</sub>	E	е	e <sub>1</sub>	j	к	٦	L <sub>1</sub>	L <sub>2</sub> <sup>(1)</sup> max.	Р	Q	q	T <sup>(2)</sup>	w
mm	4.6 4.0	2.9 2.5	0.9 0.7	1.1 0.9	1.4 1.0	0.7 0.4	15.8 15.2	6.5 6.3	10.3 9.7	2.54	5.08	2.7 1.7	0.6 0.4	14.4 13.5	3.30 2.79	3	3.2 3.0	2.6 2.3	3.0 2.6	2.5	0.4

#### Notes

- 1. Terminal dimensions within this zone are uncontrolled.
- 2. Both recesses are  $\boxtimes$  2.5 × 0.8 max. depth

OUTLINE		REFER	EUROPEAN	ISSUE DATE			
VERSION	IEC	JEDEC	JEITA		PROJECTION	ISSUE DATE	
SOT186A		3-lead TO-220F				<del>-02-04-09-</del> 06-02-14	

Silicon diffused power transistor

# 12. Revision history

### **Table 9. Revision history**

Document ID	Release date	Data sheet status	Change notice	Supersedes						
PHE13005X v.3	20180426	Product data sheet	-	PHE13005X_2						
Modifications:	Change from NXP version to WeEn version									
PHE13005X_2	2091120	Product data sheet	-	PHE13005X_1						
Modifications:	Various changes to content.									
PHE13005X_1	20080515	Product data sheet	-	-						

### Silicon diffused power transistor

### 13. Legal information

#### Data sheet status

Document status [1][2]	Product status [3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

- Please consult the most recently issued document before initiating or completing a design.
- [2] The term 'short data sheet' is explained in section "Definitions".
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## Silicon diffused power transistor

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For more information, please visit: http://www.ween-semi.com
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Date of release: 26 April 2018

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